FORM PTO 1449 (modified) U.S. DEPARTMENT OF COMMERCE PATENT AND TRADEMARK OFFICE LIST OF REFERENCES CITED BY APPLICANT(S) (Use several sheets if necessary) Submitted to the PTO: September 16, 2003				ATTY DOCKET NO. 00862.002815.1	APPLICATION NO. To be assigned				
			4	APPLICANTS MITSUTOSHI KUNO, ET AL.					
							GROUP 2674		
				S. PATENT DOCUMENTS					
									
*EXAMINER INITIAL	DOCUMENT NUMBER	DATE		NAME	C	CLASS	SUBCLASS	FILING DATE	
DQD	4,816,819	03/1989		Enari, et al.		340	811		
	4,904,895	02/1990		Tsukamoto, et al.		313	336		
	5,066,833	11/1991		Zalenski		178	19		
	3,946,381	03/1976		Johnson, et al.		340	173 R		
	5,136,397	08/1992		Miyashita		358	236		
\bigvee	5,428,370	06/1995		Knapp, et al.		345	205		
DQD	5,834,900	11/1998		Tanaka, et al.		315	169.1		
			FORE	IGN PATENT DOCUMENTS					
DQD	DOCUMENT NUMBER	DATE		COUNTRY		LASS	SUBCLASS	TRANSLATION YES/NO/ OR ABSTRACT	
	3-55738	03/1991		Japan				Abstract	
	2-257551	10/1990		Japan				Abstract	
	4-28137	01/1992		Japan				Abstract	
\vee	64-31332	02/1989		Japan				Abstract	
DQD	3-207181	09/1991		Japan				Abstract	
		OTHER DOCU	IMENT(S) (II	ncluding Author, Title, Date, Pertinent F	Pages, Etc.)				
DQD	W.P. Dyke, e pp. 89-185 (1		Emissio	on", Advances in Electro	onics and Elec	tron	Physics, '	Vol. VIII,	
		C.A. Spindt, et al., "Physical Properties of Thin-Film Field Emission Cathodes with Molybdenum Cones", Journal of Applied Physics, Vol. 47, No. 12, pp. 5248-5263 (December 1976).							
		M.I. Elinson, et al., "The Emission of Hot Electrons and the Field Emission of Electrons From Tin Oxide", Radio Engineering and Electronic Physics, No. 7, pp. 1290-1296 (July 1965).							
DQD	G. Dittmer, "Electrical Conduction and Electron Emission of Discontinuous Thin Films", Thin Solid Films, Vol. 9, pp. 317-328 (1972).								
EXAMINER	/Duc Q Din			DATE CONSIDERED	10/2	5/20	006		

DATE CONSIDERED

Sheet_1_ of _3_

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(Use several sheets if necessary) Submitted to the PTO: September 16, 2003			FILING DATE September 16, 2003		GROUP 2674			
			U.S. PATENT DOCUMENTS		.074			
-			CO. PALA BOSSINETTO					
*EXAMINER INITIAL	DOCUMENT NUMBER	DATE	NAME	CLASS	SUBCLASS	FILING DATE		
DQD	6,121,942	10/2000	Sanou, et al.	345	75			
	6,144,154	11/2000	Yamazaki, et al.	313	495			
	5,347,292	10/2000	Ge, et al.	345	74			
	6,278,421	06/2001	Ishida, et al.	345	63			
	6,005,540	12/1999	Shinjo, et al.	345	74.1			
\vee	5,760,538	06/1998	Mitsutake, et al.	313	422			
DQD	6,506,087	01/2003	Fushimi, et al.	445	24			
			FOREIGN PATENT DOCUMENTS					
	DOCUMENT NUMBER	DATE	COUNTRY	CLASS	SUBCLASS	TRANSLATION YES/NO/ OR ABSTRACT		
DQD	11-288248	10/1999	Japan			Abstract		
	9-190160	07/1997	Japan			Abstract		
	8-22022	01/1996	Japan			Abstract		
	11-288249	10/1999	Japan			Abstract		
	8-30220	02/1996	Japan			Abstract		
DQD	2-39678	02/1990	Japan			Abstract		
· · · · · · · · · · · · · · · · · · ·		OTHER DOCL	JMENT(S) (Including Author, Title, Date, Pertinent Pages, Etc.)					
DQD			ng Electron Emission From Patterned Tin evices Meeting, pp. 519-521 (1975).	-Indium C	Oxide Thin	Films,		
H. Araki, et al., "Electroforming and Electron Emission of Carbon Thin Films", Journal Vacuum Society of Japan, Vol. 26, No. 1, pp. 22-29 (January 26, 1983).								
		C.A. Mead, "Operation of Tunnel-Emission Devices", Journal of Applied Physics, Vol. 32, No. 4, pp. 646-652 (April 1961).						
DQD		R. Meyer, "Recent Development of "Microtips" Display at LETI", Technical Digest of IVMC 91, pp. 7-9 (1991).						

DATE CONSIDERED

EXAMINER

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10/25/2006

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(Use several sheets if necessary) Submitted to the PTO: September 16, 2003			FILING DATE September 16, 2003 GROUP 2674			
			U.S. PATENT DOCUMENTS			
*EXAMINER INITIAL	DOCUMENT NUMBER	DATE	NAME	CLASS SUBCLA		FILING DATE IF APPROPRIATE
DQD	6,441,544	08/2002	Ando, et al.	313	310	
DQD	6,512,329	01/2003	Mitsutake, et al.	313 495		
			FOREIGN PATENT DOCUMENTS			
	DOCUMENT NUMBER	DATE	COUNTRY	CLASS	SUBCLASS	TRANSLATION YES/NO/ OR ABSTRACT
DQD	0 878 788	11/1998	Europe			
	0 655 722	05/1995	Europe			
	60-93741	05/1985	Japan			Abstract
	WO 99/24961	05/1999	PCT			
	2 747 505	10/1997	France			
	9-199006	07/1997	Japan			Abstract
	10-0220216	06/1999	Korea			No
	0 690 472	01/1996	Europe			
	9-9181	01/1997	Japan			Abstract
	0 725 420	08/1996	Europe			
	0 604 930	07/1994	Europe			
V	0 688 035	12/1995	Europe			
DQD	0 661 726	07/1995	Europe			
		OTHER DOCUM	ENT(S) (Including Author, Title, Date, Pertinent Pages, Etc.)		

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